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("dirt map") AND (vertex vertices
point coordinate reflect reflecting
reflected reflectivity)
☐
☐

▲
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("specularity modulation") AND
(vertex vertices point coordinate
reflect reflecting reflected
reflectivity)
☐

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(("specularity adj modulation")) (vertex vertices point coordinate) (reflect reflecting reflected reflection reflectivity)">

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 (vertex vertices point coordinate) (reflect reflecting reflected reflection reflectivity)">**OR**

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